Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/521,508	HAN ET AL.	
Examiner	Art Unit	
Yong Chu	1626	

SEARCHED			
	JLAN	CHLD	,
Class	Subclass	Date	Examiner
548	186	4/4/2006	YC
514	369	4/4/2006	YC
548	253	4/4/2006	YC
514	382	4/4/2006	YC

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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	EARCH NOTES G SEARCH STRA	TEGY)	
	DA	TE EX	MR
STN	4/3/	2006 Y	c
EAST	4/4/	2006 Y	c
PALM	4/4/	2006 Y	c
